


<b>Issue Classification</b> 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/751,705	HOSHINO, KIYO	
	Examiner	Art Unit	
	Dwayne J. White	3745	

ISSUE CLASSIFICATION										
ORIGINAL					CROSS REFERENCE(S)					
CLASS		SUBCLASS			CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)				
416		62			416	132A	240			
INTERNATIONAL CLASSIFICATION										
F	0	1	D	05/00						
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<i>Dwayne J. White</i> Dwayne J. White (11/10/05) (Assistant Examiner) (Date)	<i>Edward K. Look</i> EDWARD K. LOOK SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 3700 (Patent Examiner) (Date)	Total Claims Allowed: 58
<i>H. Cooper</i> (H. Cooper) (Date)		O.G. Print Claim(s) 1
		O.G. Print Fig. 2A

<input checked="" type="checkbox"/> Claims renumbered in the same order as presented by applicant										<input type="checkbox"/> CPA			<input type="checkbox"/> T.D.			<input type="checkbox"/> R.1.47	
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